

<b>Notice of References Cited</b>	Application/Control No. 09/995,378		Applicant(s)/Patent Under Reexamination OHNO, TOMOYUKI	
	Examiner Son P. Huynh		Art Unit 2623	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,763,522	07-2004	Kondo et al.	725/39
*	C	US-6,732,371	05-2004	Lee et al.	725/41
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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